| IPE | | DISCLOSUF | ATTY. DOCKET NO. 2336-252 | | U.S. PATENT APPLICATION NO. 10/791,850 | | | | | |
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

INFORMATION DISCESSERE CITATION IN AN APPLICATION

ATTY. DOCKET NO. 2336-252

U.S. PATENT APPLICATION NO. 10/791,850

APPLICANT
Yoo Sam NA et al.

FILING DATE **GROUP** (PTO-1449) March 4, 2004 2817 **U.S. PATENT DOCUMENTS EXAMINER'S** FILING INITIALS PATENT NO. DATE NAME **CLASS SUBCLASS** DATE 2004/0048594 A1 3/2004 Okanobu LL FOREIGN PATENT DOCUMENTS **EXAMINER'S** Translation PATENT NO. DATE COUNTRY SUBCLASS **CLASS** INITIALS 2000-118795 4/2000 LLJapan X 2002-368642 12/2002 LL Japan (US 2004/48594) 9-172385 6/1997 Japan X LL2002-300053 LL 10/2002 Japan X OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.) **EXAMINER** DATE CONSIDERED /Lana Le/ 06/20/2006

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| INFO | ORMATION | ATTY. DOCKET 2336-252 | U.S. PATENT APPLICATION NO. 10/791,850 | | | | | | | |
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